

| | | | |
|-----------------------------------|---------------------------------------|--|-------------|
| Notice of References Cited | Application/Control No. 10/083,376 | Applicant(s)/Patent Under Reexamination MIYAKOSHI ET AL. | |
| | Examiner Tuan C To | Art Unit 3663 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------------|----------------|
| | A | US-2001/0055974 | 12-2001 | Bates et al. | 455/456 |
| | B | US-5,767,795 | 06-1998 | Schaphorst, Richard A. | 340/988 |
| | C | US-6,564,070 | 05-2003 | Nagamine et al. | 455/556.1 |
| | D | US-6,334,087 | 12-2001 | Nakano et al. | 701/208 |
| | E | US-2001/0004739 | 06-2001 | Sekiguchi et al. | 707/100 |
| | F | US-2001/0024517 | 09-2001 | Labelle, Lilian | 382/170 |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.